CN65813

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

CB TEST CERTIFICATE

Fuse-link for the Protection of Semiconductor Device **Product**

Zhejiang Tengen Electric Co.,Ltd. Name and address of the applicant

Sulv Industrial Area, Liushi Town, Yueqing City, Zhejiang

Province, P.R.China

Zhejiang Tengen Electric Co.,Ltd. Name and address of the manufacturer

Sulv Industrial Area, Liushi Town, Yueqing City, Zhejiang

Province, P.R.China

Zhejiang Tengen Electric Co.,Ltd. Name and address of the factory

No.332 Liule Road, Liushi Town, Yueqing City, Zhejiang Note: When more than one factory, please report on page 2

Province, P.R.China

Un: Ratings and principal characteristics

DC15000V,DC1200V,DC1000V,DC750V;In:400A,450A,500A,

550A,630A,700A,800A,900A,1000A,1100A,1250A,1350A,

1500A,1600A,1800A,2000A;I1:250kA;aR

TENGEN Trademark (if any)

N/A Customer's Testing Facility (CTF) Stage used

TGRS3Z-5EP; Model / Type Ref.

Additional information (if necessary may also be reported on page 2)

A sample of the product was tested and found

to be in conformity with

03601-A-23CB0182-S

As shown in the Test Report Ref. No. which

forms part of this Certificate

CHINA QUALITY CERTIFICATION CENTRE CO., LTD.

Section 9, No. 188 Nansihuan Xilu, Beijing 100070 P. R. China Tel: +86-10-83886666 Fax: +86-10-83886282

website: http://www.cqc.com.cn

May.13,2024 Date:



IEC 60269-1:2006,IEC 60269-1:2006/AMD1:2009, IEC

60269-4:2009/AMD1:2012, IEC 60269-4:2009/AMD2:2016

60269-1:2006/AMD2:2014;IEC 60269-4:2009, IEC

